

Notice of References Cited

Application/Control No.

Applicant(s)/Patent Under

Re examination
NAKAI, TAKEHIKO

Examiner

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Art Unit

2872

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US- 5120120	6/1992	Cohen	351/161
*	B	US- 5260828	11/1993	Londano et al.	359/565
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

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